

PRODUCT RELIABILITY REPORT FOR

DS1683

Maxim Integrated Products

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Prepared by:

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Conclusion:

The following qualification successfully meets the quality and reliability standards required of all Maxim products:

DS1683

In addition, Maxim's continuous reliability monitor program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards. The current status of the reliability monitor program can be viewed at http://www.maxim-ic.com/TechSupport/dsreliability.html.

Device Description:

A description of this device can be found in the product data sheet. You can find the product data sheet at http://dbserv.maxim-ic.com/l datasheet3.cfm.

Reliability Derating:

The Arrhenius model will be used to determine the acceleration factor for failure mechanisms that are temperature accelerated.

```
AfT = exp((Ea/k)*(1/Tu - 1/Ts)) = tu/ts
AfT = Acceleration factor due to Temperature
tu = Time at use temperature (e.g. 55°C)
ts = Time at stress temperature (e.g. 125°C)
k = Boltzmann's Constant (8.617 x 10-5 eV/°K)
Tu = Temperature at Use (°K)
Ts = Temperature at Stress (°K)
Ea = Activation Energy (e.g. 0.7 ev)
```

The activation energy of the failure mechanism is derived from either internal studies or industry accepted standards, or activation energy of 0.7ev will be used whenever actual failure mechanisms or their activation energies are unknown. All deratings will be done from the stress ambient temperature to the use ambient temperature.

An exponential model will be used to determine the acceleration factor for failure mechanisms, which are voltage accelerated.

```
AfV = exp(B*(Vs - Vu))

AfV = Acceleration factor due to Voltage

Vs = Stress Voltage (e.g. 7.0 volts)

Vu = Maximum Operating Voltage (e.g. 5.5 volts)

B = Constant related to failure mechanism type (e.g. 1.0, 2.4, 2.7, etc.)
```

The Constant, B, related to the failure mechanism is derived from either internal studies or industry accepted standards, or a B of 1.0 will be used whenever actual failure mechanisms or their B are unknown. All deratings will be done from the stress voltage to the maximum operating voltage. Failure rate data from the operating life test is reported using a Chi-Squared statistical model at the 60% or 90% confidence level (Cf).

The failure rate, Fr, is related to the acceleration during life test by:

```
Fr = X/(ts * AfV * AfT * N * 2)
X = Chi-Sq statistical upper limit
N = Life test sample size
```

Failure Rates are reported in FITs (Failures in Time) or MTTF (Mean Time To Failure). The FIT rate is related to MTTF by:

MTTF = 1/Fr

NOTE: MTTF is frequently used interchangeably with MTBF.

The calculated failure rate for this device/process is:

FAILURE RATE: MTTF (YRS): 55205 FITS: 2.1

DEVICE HOURS: 977988844 FAILS: 1

Only data from Operating Life or similar stresses are used for this calculation.

The parameters used to calculate this failure rate are as follows:

Cf: 60% Ea: 0.7 B: 0 Tu: 25 °C Vu: 5.5 Volts

The reliability data follows. At the start of this data is the device information. The next section is the detailed reliability data for each stress. The reliability data section includes the latest data available and may contain some generic data. **Bold** Product Number denotes specific product data.

Device Information:

Process: SA E6W, 0.6um BiCMOS, 2 Poly, 2 Metal, EEPROM, 8 inch wafer

Passivation: TEOS Oxide-Nitride Passivation

Die Size: 85 x 135 Number of Transistors: 29787

Interconnect: Aluminum / 0.5% Copper

Gate Oxide Thickness: 150 Å

ESD HBM									
DESCRIPTION	DATE	CODE/PRODUCT/	LOT	CONDITION	READ	POIN	QTY	FAILS	FA#
ESD SENSITIVITY	1224	DS1683	ZD280142AB	JESD22-A114 HBM 500 VOLTS	1	PUL'S	5	0	
ESD SENSITIVITY	1224	DS1683	ZD280142AB	JESD22-A114 HBM 1000 VOLTS	1	PUL'S	5	0	
ESD SENSITIVITY	1224	DS1683	ZD280142AB	JESD22-A114 HBM 1500 VOLTS	1	PUL'S	5	0	
ESD SENSITIVITY	1224	DS1683	ZD280142AB	JESD22-A114 HBM 2000 VOLTS	1	PUL'S	5	0	
ESD SENSITIVITY	1224	DS1683	ZD280142AB	JESD22-A114 HBM 2500 VOLTS	1	PUL'S	5	0	
				Total:			0		

LATCH-UP								
DESCRIPTION	DATE	CODE/PRODUCT/	LOT	CONDITION	READPOIN	QTY	FAILS	FA#
LATCH-UP I	1224	DS1683	ZD280142AB	JESD78A, I-TEST 25C 100mA		6	0	
LATCH-UP I	1224	DS1683	ZD280142AB	JESD78A, I-TEST 25C 250mA		6	0	
LATCH-UP V	1224	DS1683	ZD280142AB	JESD78A, V-SUPPLY TEST 25C		6	0	
					Total:		0	

OPERATING LIFE										
DESCRIPTION	DATE	CODE/PRODUCT	/LOT	CONDITIO	ON	REAL	OPOIN	QTY	FAILS	FA#
HIGH TEMP OP LIFE	0720	DS1851	QK707606BE	3 125C, 5.5	VOLTS	192	HRS	77	0	
HIGH TEMP OP LIFE	0948	DS1856	WM049367A	125C, 5.5	VOLTS	1000	HRS	77	1 400	23508
HIGH TEMP OP LIFE	1021	DS1804	WD049849A	125C, 5.5	VOLTS	192	HRS	45	0	
HIGH TEMP OP LIFE	1035	DS18S20	FJ157931AB	125C, 5.5	VOLTS	1000	HRS	80	0	
HIGH TEMP OP LIFE	1050	DS1856	WM158219A	125C, 5.5	VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1050	DS1856	WM158219A	125C, 5.5	VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1052	DS1856	FJ162135DB	125C, 5.5	VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1052	DS1856	FJ162135DB	125C, 5.5	VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1052	DS1856	FJ162076CC	125C, 5.5	VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1052	DS1856	FJ162076CC	125C, 5.5	VOLTS	1000	HRS	77	0	
HIGH TEMP OP LIFE	1103	DS18S20	FD162367AC	125C, 5.5	VOLTS	1000	HRS	80	0	
HIGH TEMP OP LIFE	1113	DS18S20	FD166067AB	125C, 5.5	VOLTS	1000	HRS	80	0	
HIGH TEMP OP LIFE	1113	DS3911	ZJ167332AB	- 125C, 5.5	VOLTS	192	HRS	48	0	
HIGH TEMP OP LIFE	1128	DS18S20	FH167920AB	125C, 5.5	VOLTS	1000	HRS	80	0	
HIGH TEMP OP LIFE	1138	DS18S20	FD271756AB	125C, 5.5	VOLTS	1000	HRS	80	0	
HIGH TEMP OP LIFE	1207	DS1886	ZJ276689AA	- 125C, 3.6	VOLTS	192	HRS	80	0	
HIGH TEMP OP LIFE	1221	DS1856M	ZJ280139AC	125C, 5.5	VOLTS	192	HRS	80	0	
HIGH TEMP OP LIFE	1224	DS1683	ZD280142AB	125C, 5.5	VOLTS	240	HRS	80	0	
HIGH TEMP OP LIFE	1224	DS18S20	FJ278503AC	125C, 5.5	VOLTS	192	HRS	80	0	
FAILURE RATE:		MTTE (VDC)	\. <i>EE</i>	205	FITS:	Total:	:		1	
FAILUKE KATE:		MTTF (YRS)) . 55	205	LI19:	∠.1				

DEVICE HOURS: 977988844 FAILS:

1